

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,300	CHIEN, JINN-YEH	
Examiner	Art Unit	
Christine T. Tu	2138	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
714	724	9/22/2006	CTLT	
377	64	9/22/2006	CTLT	
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SEARCH NOT (INCLUDING SEARCH :		)
	DATE	EXMR
(714/724,726,727,728,729,738,739,30 ) & (377/64,77,81) & text	9/22/2006	CTLT